SCLS050 – MARCH 1987 – REVISED APRIL 1993

- Inputs Are TTL-Voltage Compatible
- Flow-Through Architecture Optimizes PCB Layout
- Center-Pin V_{CC} and GND Configurations Minimize High-Speed Switching Noise
- *EPIC*[™] (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic Small-Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs

description

These devices contain a single 8-input NAND gate and perform the following Boolean functions in positive logic:

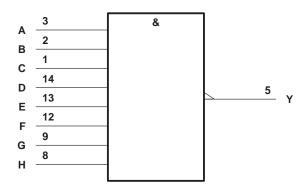
 $Y = \overline{A \bullet B \bullet C \bullet D \bullet E \bullet F \bullet G \bullet H} \text{ or}$ $Y = \overline{A + B} + \overline{C} + \overline{D} + \overline{E} + \overline{F} + \overline{G} + \overline{H}$

The 54ACT11030 is characterized for operation over the full military temperature range of -55° C to 125°C. The 74ACT11030 is characterized for operation from -40° C to 85° C.

FUNCTION TABLE

| A THRU H | Y |
|----------------------|---|
| All inputs H | L |
| One or more inputs L | Н |

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, and N packages.

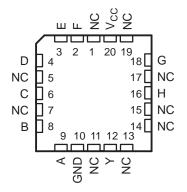
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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



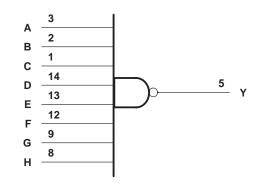
13 🛛 E вΓ 2 А 🛛 з 12**1** F Vcc GND 4 11 NC YΓ 5 10 NC 6 9 G NC 8**1** H 7

54ACT11030 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

| Supply voltage range, V _{CC} | –0.5 V to 6 V |
|-----------------------------------------------------------------------------------------|-----------------------------------|
| Input voltage range, V _I (see Note 1) | -0.5 V to V _{CC} + 0.5 V |
| Output voltage range, V _O (see Note 1) | -0.5 V to V _{CC} + 0.5 V |
| Input clamp current, I_{IK} (V _I < 0 or V _I > V _{CC}) | ±20 mA |
| Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) | ±50 mA |
| Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$ | ±50 mA |
| Continuous current through V _{CC} or GND | ±100 mA |
| Storage temperature range | 65°C to 150°C |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions

| | | 54ACT | 11030 | 74ACT | UNIT | |
|---------------------|------------------------------------|-------|-------|-------|------|------|
| | | MIN | MAX | MIN | MAX | UNIT |
| V _{CC} | Supply voltage | 4.5 | 5.5 | 4.5 | 5.5 | V |
| VIH | High-level input voltage | 2 | | 2 | | V |
| VIL | Low-level input voltage | | 0.8 | | 0.8 | V |
| VI | Input voltage | 0 | VCC | 0 | VCC | V |
| VO | Output voltage | 0 | VCC | 0 | VCC | V |
| ЮН | High-level output current | | -24 | | -24 | mA |
| IOL | Low-level output current | | 24 | | 24 | mA |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | 0 | 10 | 0 | 10 | ns/V |
| TA | Operating free-air temperature | -55 | 125 | -40 | 85 | °C |



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| PARAMETER | TEST CONDITIONS | Vee | T, | α = 25°C | ; | 54ACT | 11030 | 74ACT | 11030 | UNIT |
|----------------------------|---------------------------------------------------------------|-------|------|----------|------|-------|-------|-------|-------|------|
| FARAMETER | TEST CONDITIONS | Vcc | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT |
| | I _{OH} = – 50 μA | 4.5 V | 4.4 | | | 4.4 | | 4.4 | | |
| | 10H = -30 mA | 5.5 V | 5.4 | | | 5.4 | | 5.4 | | |
| Vou | I _{OH} = -24 mA | 4.5 V | 3.94 | | | 3.7 | | 3.8 | | V |
| | OH = -24 mA | 5.5 V | 4.94 | | | 4.7 | | 4.8 | | v |
| | $I_{OH} = -50 \text{ mA}^{\dagger}$ | 5.5 V | | | | 3.85 | | | | |
| | $I_{OH} = -75 \text{ mA}^{\dagger}$ | 5.5 V | | | | | | 3.85 | ; | |
| | I _{OL} = 50 μA | 4.5 V | | | 0.1 | | 0.1 | | 0.1 | |
| | | 5.5 V | | | 0.1 | | 0.1 | | 0.1 | |
| Vei | I _{OL} = 24 mA | 4.5 V | | | 0.36 | | 0.5 | | 0.44 | V |
| VOL | | 5.5 V | | | 0.36 | | 0.5 | | 0.44 | v |
| | $I_{OL} = 50 \text{ mA}^{\dagger}$ | 5.5 V | | | | | 1.65 | | | |
| | $I_{OL} = 75 \text{ mA}^{\dagger}$ | 5.5 V | | | | | | | 1.65 | |
| Ц | $V_I = V_{CC}$ or GND | 5.5 V | | | ±0.1 | | ±1 | | ±1 | μΑ |
| ICC | $V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$ | 5.5 V | | | 4 | | 80 | | 40 | μA |
| ΔI_{CC}^{\ddagger} | One input at 3.4 V, Other inputs at V _{CC} or GND | 5.5 V | | | 0.9 | | 1 | | 1 | mA |
| Ci | $V_{I} = V_{CC} \text{ or } GND$ | 5 V | | 3.5 | | | | | | pF |

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

[‡]This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

| PARAMETER | FROM | то | Т | _Δ = 25°C | ; | 54ACT | 11030 | 74ACT | 11030 | UNIT |
|------------------|----------|----------|-----|---------------------|-----|-------|-------|-------|-------|------|
| PARAMETER | (INPUT) | (OUTPUT) | MIN | TYP | MAX | MIN | MAX | MIN | MAX | UNIT |
| ^t PLH | A thru H | V | 1.5 | 5.4 | 8.1 | 1.5 | 8.8 | 1.5 | 8.5 | |
| ^t PHL | A thru H | Y | 1.5 | 5.9 | 7.8 | 1.5 | 9.3 | 1.5 | 8.7 | ns |

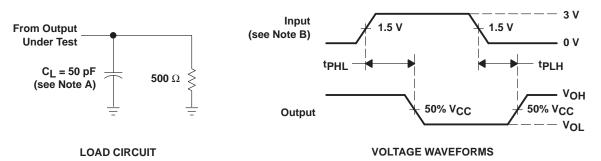
operating characteristics, V_{CC} = 5 V, T_A = 25°C

| | PARAMETER | TEST CONDITIONS | TYP | UNIT |
|-----------------|----------------------------------------|-------------------------------------------------|-----|------|
| C _{pd} | Power dissipation capacitance per gate | $C_L = 50 \text{ pF}, \qquad f = 1 \text{ MHz}$ | 41 | pF |



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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. $\ensuremath{\mathsf{CL}}$ includes probe and jig capacitance.
 - B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
 - C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| *All dimensions are nominal | |
|-----------------------------|--|
| | |

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|--------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| 74ACT11030DR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |



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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|--------------|--------------|-----------------|------|------|-------------|------------|-------------|
| 74ACT11030DR | SOIC | D | 14 | 2500 | 356.0 | 356.0 | 35.0 |

TEXAS INSTRUMENTS

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TUBE



- B - Alignment groove width

*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | Τ (μm) | B (mm) |
|-------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| 74ACT11030N | N | PDIP | 14 | 25 | 506 | 13.97 | 11230 | 4.32 |
| 74ACT11030N | N | PDIP | 14 | 25 | 506 | 13.97 | 11230 | 4.32 |

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